

T493 HRA, Tantalum, MnO2 Tantalum, HRA, 10 uF, 5%, 16 VDC, SMD, MnO2, Molded, High Reliability, N/A, 3.5 Ohms, 3528, Height Max = 2.1mm

ANODE (+) END VIEW BOTTOM VIEW BOTTOM VIEW

Click here for the 3D model.

| Dimensions | |
|------------|-----------------|
| Footprint | 3528 |
| L | 3.5mm +/-0.2mm |
| W | 2.8mm +/-0.2mm |
| Н | 1.9mm +/-0.2mm |
| Т | 0.13mm REF |
| S | 0.8mm +/-0.3mm |
| F | 2.2mm +/-0.1mm |
| Α | 1.9mm MIN |
| В | 0.4mm +/-0.15mm |
| E | 2.2mm REF |
| G | 1.8mm REF |
| Р | 0.35mm MIN |
| R | 1mm REF |
| X | 0.1mm +/-0.1mm |
| | |

| Packaging Specifications | |
|--------------------------|------------|
| Packaging | T&R, 178mm |
| Packaging Quantity | 2000 |

| General Information | |
|---------------------|---|
| Series | T493 HRA |
| Dielectric | MnO2 Tantalum |
| Style | SMD Chip |
| Description | SMD, MnO2, Molded, High Reliability |
| Features | High Reliability |
| RoHS | Yes |
| Termination | Non-Magnetic Tin |
| AEC-Q200 | No |
| Component Weight | 102.3 mg |
| Notes | P and R dimensions represents the minimum solderable area of the termination surface entirely below cutout (if one is present). |

| Specifications | |
|----------------------------|--|
| Capacitance | 10 uF |
| Capacitance Tolerance | 5% |
| Voltage DC | 16 VDC (85C), 10.72 VDC (125C) |
| Temperature Range | -55/+125°C |
| Rated Temperature | 85°C |
| Dissipation Factor | 6% 120Hz 25C |
| Failure Rate | N/A |
| Resistance | 3.5 Ohms (100kHz 25C) |
| Ripple Current | 156 mA (rms, 100kHz 25C) |
| Leakage Current | 1.6 uA (5min 25°C) |
| Testing and Reliability | 10 Cycles Surge Current Testing At +25C After Weibull |

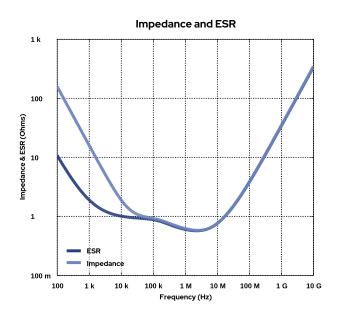
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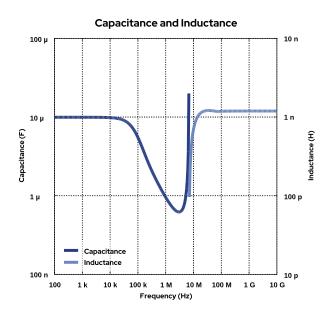


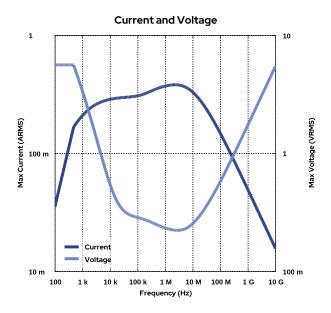
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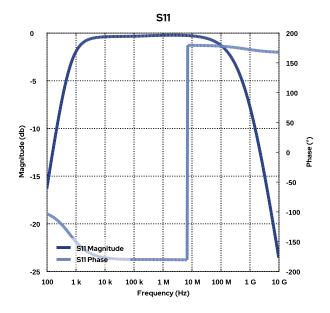
Simulations

For the complete simulation environment please visit K-SIM.



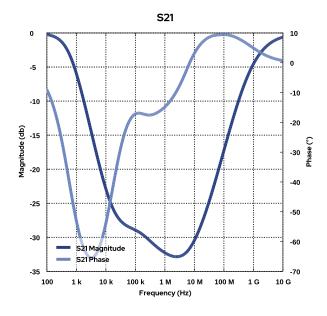








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These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.
- The ESR in the "Temperature Rise vs. Ripple Current" plots is adjusted to each incremental temperature rise before the power and ripple current is calculated.
- The effects shown herein are based on measured data from a multiple part sample of the parts in question.
- Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

 The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages generated at any other
- Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

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